

EMC Technologies Pty Ltd

ABN 82 057 105 549 176 Harrick Road Keilor Park Victoria Australia 3042

Ph: + 613 9365 1000 Fax: + 613 9331 7455 email: melb@emctech.com.au

SAR Test Report

Report Number: M161013

Test Sample: Cellsafe Lif3 for Apple iPhone 7 and 7

Plus phones

Phone Types: Apple iPhone 7 and 7 Plus phones

Tested For: Cellsafe Pty Ltd

Date of Issue: 21st November 2016

EMC Technologies Pty Ltd reports apply only to the specific samples tested under stated test conditions. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. EMC Technologies Pty Ltd shall have no liability for any deductions, inferences or generalisations drawn by the client or others from EMC Technologies Pty Ltd issued reports. This report shall not be used to claim, constitute or imply product endorsement by EMC Technologies Pty Ltd.





Accredited for compliance with ISO/IEC 17025. The results of the test, calibrations and/or measurement included in this document are traceable to Australian/national standards. NATA is a signatory to the ILAC Mutual Recognition Arrangement for the mutual recognition of the equivalence of testing, calibration and inspection reports.

This document shall not be reproduced except in full.

CONTENTS

1.0	GENERAL INFORMATION	3
2.0	DESCRIPTION OF DEVICE	4
	2.1 Description of Test Sample	
	2.2 Test sample Accessories	4
	2.2.1 Battery Types	
	2.3 Test Signal, Frequency and Output Power	4
	2.4 Conducted Power Measurements	4
	2.5 Battery Status	
	2.6 Details of Test Laboratory	
	2.6.1 Location	
	2.6.2 Accreditations	
	2.6.3 Environmental Factors	6
3.0	CALIBRATION AND VERIFICATION PROCEDURES AND DATA	6
	3.1.1 Deviation from reference values	6
	3.1.2 Temperature and Humidity	6
4.0	SAR MEASUREMENT PROCEDURE USING DASY5	7
5.0	MEASUREMENT UNCERTAINTY	8
6.0	EQUIPMENT LIST AND CALIBRATION DETAILS	
7.0	SAR TEST METHOD	11
	7.1 Description of the Test Positions (Head and Body Sections)	
	7.1.1 "Touch Position"	11
	7.2 List of All Test Cases (Antenna In/Out, Test Frequencies, User Modes etc)	. 11
	7.3 ARPANSA RF Exposure Limits for ACMA (Australia) and EN 50360	. 11
8.0	SAR EVALUATION RESULTS	12
	B.1 SAR Measurement Results for UMTS Bands iPhone 7	
	8.2 SAR Measurement Results for UMTS Bands iPhone 7 Plus	
	COMPLIANCE STATEMENT	
	ENDIX A1 Test Sample Photographs	
	NDIX A2 Test Setup Photographs	
	NDIX A3 Test Setup Photographs	
	NDIX A4 Test Sample Photographs	
	NDIX A5 Test Setup Photographs	
	NDIX A6 Test Setup Photographs	
	NDIX B Plots Of The SAR Measurements	
APP	ENDIX C DESCRIPTION OF SAR MEASUREMENT SYSTEM	
	Probe Positioning System	
	E-Field Probe Type and Performance	
	Data Acquisition Electronics	
	Device Holder for DASY5	
	Liquid Depth 15cm	
	Phantom Properties (Size, Shape, Shell Thickness, Tissue Material Properties)	
	Simulated Tissue Composition Used for SAR Test	
APP	ENDIX D CALIBRATION DOCUMENTS	44





Report No.: M161013 Page 3 of 76

SAR Test Report

Cellsafe Lif3 for Apple iPhone 7 and 7 Plus phones,

Type: Apple iPhone 7 and 7 Plus phones Report Number: M161013

1.0 GENERAL INFORMATION

Test Sample: Cellsafe Lif3 for Apple iPhone 7 and 7 Plus phones

Model Number: Apple iPhone 7 and 7 Plus phones

Type:	iPhone 7	iPhone 7 Plus
Model Number:	MN8X2X/A	MN4W2X/A
Serial Number:	C6KSC3BQHG7F	C39SGABDHFYF

Manufacturer: Samsung Electronics, and Apple Inc

Device Category: Portable Transmitter **Test Device: Production Unit**

RF exposure Category: General Public/Unaware user

Tested for: Cellsafe Pty Ltd

Address: 14/1866 Princes Hwy, Clayton, Vic 3168

Contact: Nicole Bennett Phone: +61 3 9544 4886 Email: sales@cellsafe.com.au Tested for: Cellsafe Pty Ltd

Test Standard/s:

1. Maximum Exposure Levels to Radiofrequency Fields – 3kHz to

300GHz, ARPANSA

2. EN 62209-1:2006 and EN 62209-2:2010

> Human exposure to radio frequency fields from hand-held and bodymounted devices-Human models, instrumentation and procedures. Part 1: Procedure to determine the specific absorption rate (SAR) for hand- held devices used in close proximity to the ear (frequency range 300 MHz to 3 GHz)

Part 2: Procedure to determine the specific absorption rate (SAR) for wireless communication devices used in close proximity to the human

body (frequency range of 30 MHz to 6 GHz

Conclusion: The Cellsafe Lif3 for Apple iPhone 7 and 7 Plus phones, Types: Apple

iPhone 7 and 7 Plus phones, were tested according to EN 50360, New Zealand and Australian Communications and Media Authority requirements for human exposure to radio frequencies. The Cellsafe Lif3 device was found to decrease SAR in the configurations described

in this report by up to 87.2%.

14th and 15th November 2016 **Test Dates:**

Peter Jakubiec

Authorised Signature:

Chris Zombolas Technical Director



Test Officer:



Report No.: M161013 Page 4 of 76

2.0 DESCRIPTION OF DEVICE

2.1 Description of Test Sample

The devices tested were Apple iPhone 7 and 7 Plus mobile phones fitted with Cellsafe Lif3 RF reduction chip, and they were tested in the 850 and 1900 MHz WCDMA frequency bands. They will be referred to as the Devices Under Test (DUTs) throughout this report. The DUTs were tested in the Body Back of phone position.

Table: DUT (Device Under Test) Parameters

Operating Mode During Testing	:See Clause 2.3
Operating Mode Production Sample	: UMTS
Modulation:	: QPSK
Antenna type	: Internal
Applicable Head Configurations	: None
Applicable Body Worn-Configurations	: Body back
Battery Options	: Internal non removable Li-ion

2.2 Test sample Accessories

Battery Types

SAR measurements were performed with the standard Li-ion V battery.

2.3 Test Signal, Frequency and Output Power

The DUTs were provided by Cellsafe Pty Ltd and put into operation using a Rhodes & Schwarz Communication Tester CMU200. The channels and power classes utilised in the measurements are listed in the tables below.

The SAR level of the test sample was measured for the frequency bands as shown in the table below. Communication between the tester and the DUT was maintained by an air link.

Table: Test Frequencies and Power Classes

Band	Free	Frequency (MHz)			ffic Chanr	Band Power	Nominal Power	
	Low	Mid	High	Low Mid High			Class	(dBm)
UMTS Band 5	N/A	836.6	N/A	N/A	4183	N/A	3	24
UMTS Band 2	N/A	1880.0	N/A	N/A	9400	N/A	3	24

2.4 Conducted Power Measurements

The conducted power of the DUT was not measured because the devices do not have an accessible RF test port.





2.5 Battery Status

The DUT battery was fully charged prior to commencement of each measurement. The battery condition was monitored by measuring the RF power at a defined position inside the phantom before the commencement of each test and again after the completion of the test.

2.6 Details of Test Laboratory

Location 2.6.1

EMC Technologies Pty Ltd 176 Harrick Road Keilor Park, (Melbourne) Victoria Australia 3042

+61 3 9365 1000 Telephone: Facsimile: +61 3 9331 7455 email: melb@emctech.com.au website: www.emctech.com.au

Accreditations 2.6.2

EMC Technologies Pty. Ltd. is accredited by the National Association of Testing Authorities, Australia (NATA). NATA Accredited Laboratory Number: 5292

Last assessed in February 2014, next scheduled assessment in February 2017

EMC Technologies Pty Ltd is NATA accredited for the following RF Human Exposure standards:

AS/NZS 2772.2 2011: Radiofrequency Fields.

Part 2: Principles and methods of measurement and computation - 3kHz to

300 GHz.

ACMA: Radiocommunications (Electromagnetic

Radiation — Human Exposure) Standard 2003

Product standard to demonstrate the compliance of Mobile Phones with the EN 50360: 2001

basic restrictions related to human exposure to electromagnetic fields (300

MHz - 3 GHz)

EN 62209-1:2006 Human exposure to radio frequency fields from hand-held and body-

mounted devices-Human models, instrumentation and procedures.

Part 1: Procedure to determine the specific absorption rate (SAR) for handheld devices used in close proximity to the ear (frequency range 300 MHz

to 3 GHz)

EN 62209-2:2010 Human Exposure to radio frequency fields from hand-held and body-

mounted wireless communication devices - Human models instrumentation

and procedures

Part 2: Procedure to determine the specific absorption rate (SAR) for wireless communication devices used in close proximity to the human body

(frequency range of 30 MHz to 6 GHz

IEEE 1528: 2013 Recommended Practice for Determining the Peak Spatial-Average Specific

Absorption Rate (SAR) in the Human Head Due to Wireless

Communications Devices: Measurement Techniques.

Refer to NATA website www.nata.asn.au for the full scope of accreditation.





2.6.3 Environmental Factors

The measurements were performed in a shielded room with no background RF signals. The temperature in the laboratory was controlled to within 20 ± 1 °C, the humidity was in the range 46% to 50%. See section 3.1.2 for measured temperature and humidity. The liquid parameters were measured daily prior to the commencement of each test. Tests were performed to check that reflections within the environment did not influence the SAR measurements. The noise floor of the DASY5 SAR measurement system using the ET3DV6 E-field probe is less than $5\mu V$ in both air and liquid mediums.

3.0 CALIBRATION AND VERIFICATION PROCEDURES AND DATA

Prior to the SAR assessment, the system verification kit was used to verify that the DASY5 was operating within its specifications. The system check was performed at the frequencies listed below using the SPEAG calibrated dipoles. The reference dipoles are highly symmetric and matched at the centre frequency for the specified liquid and distance to the phantom. The accurate distance between the liquid surface and the dipole centre is achieved with a distance holder that snaps onto the dipole. System verification is performed by feeding a known power level into a reference dipole, set at a known distance from the phantom. The measured SAR is compared to the theoretically derived level, and must be within ±10%.

3.1.1 Deviation from reference values

The EN62209 reference SAR values are derived numerically for a given phantom and dipole construction, at the frequencies listed below. These reference SAR values are obtained from the EN62209 standard and are normalized to 1W.

The SPEAG calibration reference SAR value is the SAR validation result obtained in a specific dielectric liquid using the verification dipole during calibration. The measured ten-gram SAR should be within ±10% of the expected target reference values shown in table below.

Table: Deviation from reference validation values

Date	Frequency (MHz)	Measured SAR 10g (input power = 250mW)	Measured SAR 10g (Normalized to 1W)	SPEAG Calibration Reference SAR Value 10g (mW/g)	Deviation From SPEAG 10g (%)	EN62209 Reference SAR Value 10g (mW/g)	Deviation From EN62209 10g (%)
14 th Nov. 16	900	1.72	6.88	6.79	1.33	6.99	-1.57
14 th Nov. 16	1800	4.73	18.92	20.1	-5.87	20.1	-5.87
15 th Nov. 16	900	1.76	7.04	6.79	3.68	6.99	0.72
15 th Nov. 16	1800	4.78	19.12	20.1	-4.88	20.1	-4.88

Note: All reference SAR values are normalized to 1W input power.

3.1.2 Temperature and Humidity

The humidity and dielectric/ambient temperatures are recorded during the assessment of the tissue material dielectric parameters. The difference between the ambient temperature of the liquid during the dielectric measurement and the temperature during tests was less than |2|°C.

Table: Temperature and Humidity recorded for each day

Date		Ambient	Liquid	Humidity (%)
	T	emperature (°C)	Temperature (°C)	
14 th Novembe		20.3	20.0	50
15 th Novembe	er 2016	20.3	20.1	46





4.0 SAR MEASUREMENT PROCEDURE USING DASY5

The SAR evaluation was performed with the SPEAG DASY5 System **Version 52 (Build 1222)**. A summary of the procedure follows:

a) A measurement of the SAR value at a fixed location is used as a reference value for assessing the power drop of the DUT. The SAR at this point is measured at the start of the test and then again at the end of the test.

Report No.: M161013 Page 7 of 76

- b) The SAR distribution at the exposed side of the head or the flat section of the flat phantom is measured at a distance of 4.0 mm from the inner surface of the shell. The area covers the entire dimension of the DUT and the horizontal grid spacing is 15 mm x 15 mm. The actual largest Area Scan has dimensions of 120 mm x 220 mm surrounding the test device. Based on this data, the area of the maximum absorption is determined by Spline interpolation.
- c) Around this point, a volume of 32 mm x 32 mm x 30 mm is assessed by measuring 5 x 5 x 7 points. On the basis of this data set, the spatial peak SAR value is evaluated with the following procedure:
 - (i) The data at the surface are extrapolated, since the centre of the dipoles is 2.7 mm away from the tip of the probe and the distance between the surface and the lowest measuring point is 4 mm. The extrapolation is based on a least square algorithm. A polynomial of the fourth order is calculated through the points in z-axes. This polynomial is then used to evaluate the points between the surface and the probe tip.
 - (ii) The maximum interpolated value is searched with a straightforward algorithm. Around this maximum the SAR values averaged over the spatial volumes (1 g and 10 g) are computed using the 3D-Spline interpolation algorithm. The 3D-Spline is composed of three one-dimensional splines with the "Not a knot"- condition (in x, y and z-direction). The volume is integrated with the trapezoidal algorithm. One thousand points (10 x 10 x 10) are interpolated to calculate the averages.
 - (iii) All neighbouring volumes are evaluated until no neighbouring volume with a higher average value is found.
 - (iv) The SAR value at the same location as in Step (a) is again measured and the power drift is recorded.





Report No.: M161013 Page 8 of 76

5.0 MEASUREMENT UNCERTAINTY

The uncertainty analysis is based on the template listed in the EN 62209-1 and EN62209-2 for both Handset SAR tests and Validation uncertainty. The measurement uncertainty of a specific device is evaluated independently and the total uncertainty for both evaluations (95% confidence level) must be less than 30%.

Table: Uncertainty Budget for DASY5 Version 52 (Build 1222) - DUT SAR test

Table: Uncertainty Bud	iget for	DASY5	versi	on 52	(Build	1222) -	- טטו א	AH te
Error Description	Uncert. Value	Prob. Dist.	Div.	C _i (1g)	C _i (10g)	1g u _i	10g u _i	Vi
Measurement System								
Probe Calibration	6	N	1.00	1	1	6.00	6.00	8
Axial Isotropy	4.7	R	1.73	0.7	0.7	1.90	1.90	8
Hemispherical Isotropy	9.6	R	1.73	0.7	0.7	3.88	3.88	8
Boundary Effects	1	R	1.73	1	1	0.58	0.58	∞
Linearity	4.7	R	1.73	1	1	2.71	2.71	8
System Detection Limits	1	R	1.73	1	1	0.58	0.58	∞
Modulation response	2.4	R	1.73	1	1	1.39	1.39	8
Readout Electronics	0.3	N	1.00	1	1	0.30	0.30	8
Response Time	0.8	R	1.73	1	1	0.46	0.46	8
Integration Time	2.6	R	1.73	1	1	1.50	1.50	8
RF Ambient Noise	3	R	1.73	1	1	1.73	1.73	8
RF Ambient Reflections	3	R	1.73	1	1	1.73	1.73	8
Probe Positioner	0.4	R	1.73	1	1	0.23	0.23	8
Probe Positioning	2.9	R	1.73	1	1	1.67	1.67	8
Post Processing	2	R	1.73	1	1	1.15	1.15	∞
Test Sample Related								
Power Scaling	0	R	1.73	1	1	0.00	0.00	8
Test Sample Positioning	2.9	N	1.00	1	1	2.90	2.90	145
Device Holder Uncertainty	3.6	N	1.00	1	1	3.60	3.60	8
Output Power Variation – SAR Drift Measurement	3.84	R	1.73	1	1	2.22	2.22	8
Phantom and Setup								
Phantom Uncertainty	7.6	R	1.73	1	1	4.39	4.39	∞
Liquid Conductivity – Deviation from target values	5	R	1.73	0.64	0.43	1.85	1.24	∞
Liquid Permittivity – Deviation from target values	5	R	1.73	0.6	0.49	1.73	1.41	∞
Liquid Conductivity – Measurement uncertainty	2.5	N	1.00	0.64	0.43	1.60	1.08	∞
Liquid Permittivity – Measurement uncertainty	2.5	N	1.00	0.6	0.49	1.50	1.23	∞
Temp.unc Conductivity	3.4	R	1.73	0.78	0.71	1.53	1.39	∞
Temp. unc Permittivity	0.4	R	1.73	0.23	0.26	0.05	0.06	∞
Combined standard Uncertainty (u _c)						11.68	11.45	
Expanded Uncertainty (95% CONFIDENCE LEVEL)			k=	2		23.36	22.89	

Estimated total measurement uncertainty for the DASY5 measurement system was ±11.45%. The expanded uncertainty (K = 2) was assessed to be $\pm 22.89\%$ based on 95% confidence level. The uncertainty is not added to the measurement result.





Table: Uncertainty Rudget for DASV5 Version 52 (Ruild 1992) - Validation

Report No.: M161013 Page 9 of 76

Table: Uncertainty Bu	dget for	DASY5	Vers	ion 52	2 (Build	d 1222) ·	– Valida	<u>ıtior</u>
Error Description	Uncert. Value	Prob. Dist.	Div.	C _i (1g)	C _i (10g)	1g u _i	10g u _i	Vi
Measurement System								
Probe Calibration	6	N	1.00	1	1	6.00	6.00	8
Axial Isotropy	4.7	R	1.73	1	1	2.71	2.71	8
Hemispherical Isotropy	9.6	R	1.73	0	0	0.00	0.00	8
Boundary Effects	1	R	1.73	1	1	0.58	0.58	8
Linearity	4.7	R	1.73	1	1	2.71	2.71	8
System Detection Limits	1	R	1.73	1	1	0.58	0.58	8
Modulation response	0	R	1.73	1	1	0.00	0.00	8
Readout Electronics	0.3	N	1.00	1	1	0.30	0.30	8
Response Time	0	R	1.73	1	1	0.00	0.00	8
Integration Time	0	R	1.73	1	1	0.00	0.00	8
RF Ambient Noise	1	R	1.73	1	1	0.58	0.58	8
RF Ambient Reflections	1	R	1.73	1	1	0.58	0.58	8
Probe Positioner	0.8	R	1.73	1	1	0.46	0.46	8
Probe Positioning	6.7	R	1.73	1	1	3.87	3.87	8
Post Processing	2	R	1.73	1	1	1.15	1.15	8
Dipole Related								
Deviation of exp. dipole	5.5	R	1.73	1	1	3.18	3.18	∞
Dipole Axis to Liquid Dist.	2	R	1.73	1	1	1.15	1.15	8
Input power & SAR drift	3.40	R	1.73	1	1	1.96	1.96	∞
Phantom and Setup								
Phantom Uncertainty	4	R	1.73	1	1	2.31	2.31	∞
Liquid Conductivity – Deviation from target values	5	R	1.73	0.64	0.43	1.85	1.24	∞
Liquid Permittivity – Deviation from target values	5	R	1.73	0.6	0.49	1.73	1.41	8
Liquid Conductivity – Measurement uncertainty	2.5	N	1.00	0.64	0.43	1.60	1.08	∞
Liquid Permittivity – Measurement uncertainty	2.5	N	1.00	0.26	0.26	0.65	0.65	8
Temp.unc Conductivity	3.4	R	1.73	0.78	0.71	1.53	1.39	8
Temp. unc Permittivity	0.4	R	1.73	0.23	0.26	0.05	0.06	∞
Combined standard Uncertainty (u _c)						10.05	9.81	
Expanded Uncertainty (95% CONFIDENCE LEVEL)			k=	2		20.10	19.63	

Estimated total measurement uncertainty for the DASY5 measurement system was $\pm 9.81\%$. The expanded uncertainty (K = 2) was assessed to be $\pm 19.63\%$ based on 95% confidence level. The uncertainty is not added to the Validation measurement result.





6.0 EQUIPMENT LIST AND CALIBRATION DETAILS

Table: SPEAG DASY5 Version 52 (Build 1222)

Equipment Type	Manufacturer	Model Number	Serial Number	Calibration Due	Used For this Test?
Robot - Six Axes	Staubli	RX90BL	N/A	Not applicable	✓
Robot Remote Control	SPEAG	CS7MB	RX90B	Not applicable	√
SAM Phantom	SPEAG	N/A	1260	Not applicable	✓
SAM Phantom	SPEAG	N/A	1060	Not applicable	✓
Flat Phantom	AndreT	10.1	P 10.1	Not Applicable	
Flat Phantom	AndreT	9.1	P 9.1	Not Applicable	
Flat Phantom	SPEAG	ELI 4.0	1101	Not Applicable	
Data Acquisition Electronics	SPEAG	DAE3 V1	359	11-Jan-2017	
Data Acquisition Electronics	SPEAG	DAE3 V1	442	07-Dec-2016	✓
Probe E-Field - Dummy	SPEAG	DP1	N/A	Not applicable	
Probe E-Field	SPEAG	ET3DV6	1380	10-Dec-2016	✓
Probe E-Field	SPEAG	ET3DV6	1377	11-June-2016	
Probe E-Field	SPEAG	ES3DV6	3029	Not Used	
Probe E-Field	SPEAG	EX3DV4	3956	15-June-2016	
Probe E-Field	SPEAG	EX3DV4	7358	11-Dec-2016	
Validation Source 150 MHz	SPEAG	CLA150	4003	3-Dec-2016	
Antenna Dipole 300 MHz	SPEAG	D300V3	1012	09-Dec-2018	
Antenna Dipole 450 MHz	SPEAG	D450V3	1074	09-Dec-2018	
Antenna Dipole 600 MHz	SPEAG	D600V3	1008	16-Oct-2018	
Antenna Dipole 750 MHz	SPEAG	D750V2	1051	13-Dec-2016	
Antenna Dipole 900 MHz	SPEAG	D900V2	047	09-Dec-2017	√
Antenna Dipole 1640 MHz	SPEAG	D1640V2	314	05-Dec-2017	
Antenna Dipole 1800 MHz	SPEAG	D1800V2	242	05-Dec-2017	✓
Antenna Dipole 1950 MHz	SPEAG	D1950V3	1113	09-Dec-2018	
Antenna Dipole 2300 MHz	SPEAG	D2300V2	1032	10-Dec-2018	
Antenna Dipole 2450 MHz	SPEAG	D2450V2	724	10-Dec-2018	
Antenna Dipole 2600 MHz	SPEAG	D2600V2	1044	13-Dec-2016	
Antenna Dipole 3500 MHz	SPEAG	D3500V2	1002	13-July-2013	
Antenna Dipole 5600 MHz	SPEAG	D5GHzV2	1008	16-Dec-2016	
RF Amplifier	EIN	603L	N/A	*In test	
RF Amplifier	Mini-Circuits	ZHL-42	N/A	*In test	✓
RF Amplifier	Mini-Circuits	ZVE-8G	N/A	*In test	
Synthesized signal generator	Hewlett Packard	86630A	3250A00328	*In test	✓
RF Power Meter	Hewlett Packard	437B	3125012786	*In test	✓
RF Power Sensor 0.01 - 18 GHz	Hewlett Packard	8481H	1545A01634	18-Oct-2017	✓
RF Power Meter	Rohde & Schwarz	NRP	101415	16-Oct-2016	
RF Power Sensor	Rohde & Schwarz	NRP - Z81	100174	19-Oct-2017	
RF Power Meter Dual	Hewlett Packard	435A	1733A05847	*In test	✓
RF Power Sensor	Hewlett Packard	8482A	2349A10114	*In test	✓
Network Analyser	Hewlett Packard	8714B	GB3510035	03-Oct-2016	
Network Analyser	Hewlett Packard	8753ES	JP39240130	03-Dec-2016	
Network Analyser	Hewlett Packard	8753D	3410A04122	04-Feb-2017	✓
Dual Directional Coupler	Hewlett Packard	778D	1144 04700	*In test	
Dual Directional Coupler	NARDA	3022	75453	*In test	✓
Thermometer	Digitech	QM7217	T-103	31-Aug-2017	✓
Thermometer	Digitech	QM7217	T-104	15-Jan-2017	

^{*} Calibrated during the test for the relevant parameters.





7.0 SAR TEST METHOD

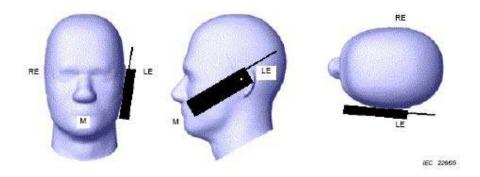
7.1 Description of the Test Positions (Head and Body Sections)

The SAR measurements are performed on the left and right sides of the head in the Touch position using the centre frequency of each operating band. See Appendix A for photos of test positions.

7.1.1 "Touch Position"

The device was positioned with the vertical centre line of the body of the device and the horizontal line crossing the centre of the earpiece in a plane parallel to the sagittal plane of the phantom. While maintaining the device in this plane, the vertical centre line was aligned with the reference plane containing the three ear and mouth reference points. (Left Ear, Right Ear and Mouth). The centre of the earpiece was then aligned with the Right Ear and Left Ear.

The Mobile Phone was then moved towards the phantom with the earpiece aligned with the line between the Left Ear and the Right Ear, until the Mobile Phone just touched the ear. With the device maintained in the reference plane, and the Mobile Phone in contact with the ear, the bottom of the Mobile Phone was moved until the front side of the Mobile Phone was in contact with the cheek of the phantom, or until contact with the ear was lost.



7.2 List of All Test Cases (Antenna In/Out, Test Frequencies, User Modes etc)

The SAR was measured at three test channels for each band of operation with the test sample operating at maximum power, as specified in section 2.3.

7.3 ARPANSA RF Exposure Limits for ACMA (Australia) and EN 50360 (Europe)

Table: SAR Exposure Limits

Spatial Peak SAR Limits For								
Head and Partial-Body: 2.0 mW/g (averaged over any 10g cube of tissue)								
Hands, Wrists, Feet and Ankles:	4.0 mW/g (averaged over 10g cube of tissue)							
Spatial A	Spatial Average SAR Limits For							
Whole Body: 0.08 mW/g								





8.0 SAR EVALUATION RESULTS

The SAR values averaged over 10 g tissue masses were determined for the sample device for the Left and Right ear configurations of the phantom and the results are given in the tables below.

The plots with the corresponding SAR distributions are contained in Appendix B of this report.

8.1 SAR Measurement Results for UMTS Bands iPhone 7

Table: SAR Measurement Results - UMTS Band 2 (1880 MHz)

	Table. SAIT Measurement results - SMTS Band 2 (1000 MIT2)										
Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 40.0 ±5% 38.0 to 42.0)	σ (target 1.40 ±5% 1.33 to 1.47)	Reduction SAR (%)		
Touch Left with RF Lif3 Chip 14-11-16	1	WCDMA - UMTS	9400	1880	0.065	0.03	38.27	1.44	86.3		
Touch Left No Chip 14-11-16	2	WCDMA - UMTS	9400	1880	0.473	-0.04	38.27	1.44	-		
Touch Right with RF Lif3 Chip 14-11-16	3	WCDMA - UMTS	9400	1880	0.113	-0.17	38.27	1.44	73.2		
Touch Right No Chip 14-11-16	4	WCDMA - UMTS	9400	1880	0.422	-0.07	38.27	1.44	-		
System Check 14-11-16	5	System Check	1	1800	4.73	0.03	38.54	1.391	-		

Note: The uncertainty of the system (± 22.89%) has not been added to the result.

Table: SAR Measurement Results – UMTS Band 5 (850 MHz)

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 41.5 ±5% 39.4 to 43.6)	σ (target 0.90 ±5% 0.86 to 0.95)	Reduction SAR (%)
Touch Left with RF Lif3 Chip 14-11-16	6	WCDMA - UMTS	4183	836.6	0.119	-0.07	41.48	0.8814	52.2
Touch Left No Chip 14-11-16	7	WCDMA - UMTS	4183	836.6	0.249	-0.05	41.48	0.8814	-
Touch Right with RF Lif3 Chip 14-11-16	8	WCDMA - UMTS	4183	836.6	0.134	0.08	41.48	0.8814	37.1
Touch Right No Chip 14-11-16	9	WCDMA - UMTS	4183	836.6	0.213	0	41.48	0.8814	-
System Check 14- 11-16	10	CW	1	900	1.72	0.01	40.76	0.9429	-

Note: The uncertainty of the system (± 22.89%) has not been added to the result.





8.2 SAR Measurement Results for UMTS Bands iPhone 7 Plus

Table: SAR Measurement Results – UMTS Band 2 (1880 MHz)

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 40.0 ±5% 38.0 to 42.0)	σ (target 1.40 ±5% 1.33 to 1.47)	Reduction SAR (%)
Touch Left 1900 MHz with Life3 Chip 15-11-16	11	WCDMA - UMTS	9400	1880	0.056 6	-0.04	38.71	1.466	64.6
Touch Left 1900 MHz No Chip 15-11- 16	12	WCDMA - UMTS	9400	1880	0.16	0.01	38.71	1.466	-
Touch Right 1900 MHz with Life3 Chip 15-11-16	13	WCDMA - UMTS	9400	1880	0.028	-0.16	38.71	1.466	87.2
Touch Right 1900 MHz No Chip 15-11- 16	14	WCDMA - UMTS	9400	1880	0.218	0.08	38.71	1.466	-
System Check 15- 11-16	15	System Check	1	1800	4.78	-0.03	38.98	1.414	-

Note: The uncertainty of the system (\pm 22.89%) has not been added to the result.

Table: SAR Measurement Results – UMTS Band 5 (850 MHz)

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 41.5 ±5% 39.4 to 43.6)	σ (target 0.90 ±5% 0.86 to 0.95)	Reduction SAR (%)
Touch Left with Lef3 Chip 15-11-16	16	WCDMA - UMTS	4183	836.6	0.149	-0.07	42.24	0.893	27.7
Touch Left No Chip 15-11-16	17	WCDMA - UMTS	4183	836.6	0.206	0.01	42.24	0.893	-
Touch Right with Life3 Chip 15-11-16	18	WCDMA - UMTS	4183	836.6	0.133	0.03	42.24	0.893	24.0
Touch Right No Chip 15-11-16	19	WCDMA - UMTS	4183	836.6	0.175	0.01	42.24	0.893	-
System Check 15- 11-16	20	CW	1	900	1.76	0.06	41.52	0.9563	-

Note: The uncertainty of the system (\pm 22.89%) has not been added to the result.





9.0 CONCLUSION

The Cellsafe Lif3 for Apple iPhone 7 and 7 Plus phones, models: MN8X2X/A, and MN4W2X/A respectively were tested on behalf of Cellsafe Pty Ltd. Cellsafe Lif3 devices were found to decrease SAR in the configurations described in this report by 27.7% to 86.3%.





APPENDIX A1 Test Sample Photographs

Photograph Number 01. DUT iPhone 7



Photograph Number 02. **DUT iPhone 7**



Photograph Number 03. DUT iPhone 7 with Chip







APPENDIX A2 Test Setup Photographs

Photograph Number 01. Touch Left Position iPhone 7



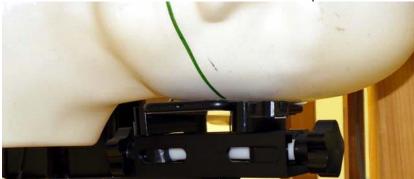
Photograph Number 02.

Touch Left Position iPhone 7



Photograph Number 03.

Touch Left Position iPhone 7 with Chip



Photograph Number 04.

Touch Left Position iPhone 7 with Chip







APPENDIX A3 Test Setup Photographs

Photograph Number 05. Tilted Right Position iPhone 7



Photograph Number 06.

Tilted Right Position iPhone 7



Photograph Number 07.

Tilted Right Position iPhone 7 with Chip



Photograph Number 08.

Tilted Right Position iPhone 7 with Chip







APPENDIX A4 Test Sample Photographs

Photograph Number 01. **DUT iPhone 7 Plus**



Photograph Number 02. DUT iPhone 7 Plus



DUT iPhone 7 Plus with Chip Photograph Number 03.







APPENDIX A5 Test Setup Photographs

Photograph Number 01. Touch Left Position iPhone 7 Plus



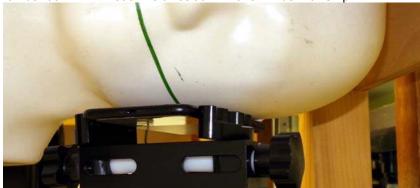
Photograph Number 02.

Touch Left Position iPhone 7 Plus



Photograph Number 03.

Touch Left Position iPhone 7 Plus with Chip



Photograph Number 04.

Touch Left Position iPhone 7 Plus with Chip







APPENDIX A6 Test Setup Photographs

Photograph Number 05. Tilted Right Position iPhone 7 Plus



Photograph Number 06.

Tilted Right Position iPhone 7 Plus



Photograph Number 07. Tilted Right Position iPhone 7 Plus with Chip



Photograph Number 08.

Tilted Right Position iPhone 7 Plus with Chip





APPENDIX B Plots Of The SAR Measurements





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Left with RF Lif3 Chip 14-11-16

Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz:

Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.44$ S/m; $\varepsilon_r = 38.3$; $\rho = 1000.0$ g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left with RF Lif3 Chip 14-11-16/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid:

dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.108 W/kg

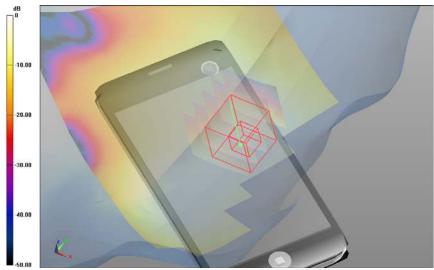
Touch Left with RF Lif3 Chip 14-11-16/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0:

Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 8.115 V/m; Power Drift =

0.03 dB

Averaged SAR: SAR(1g) = 0.099 W/kg; SAR(10g) = 0.065 W/kg

Maximum value of SAR (interpolated) = 0.132 W/kg



0 dB = 0.108 W/kg = -9.67 dBW/kg





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Left No Chip 14-11-16

Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;

Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.44$ S/m; $\varepsilon_r = 38.3$; $\rho = 1000.0$ g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left No Chip 14-11-16/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm,

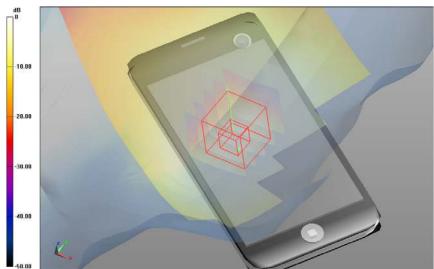
dy=1.5 mm; Maximum value of SAR (interpolated) = 0.626 W/kg

Touch Left No Chip 14-11-16/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid:

dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 22.151 V/m; Power Drift = -0.04 dB

Averaged SAR: SAR(1g) = 0.591 W/kg; SAR(10g) = 0.473 W/kg

Maximum value of SAR (interpolated) = 0.666 W/kg



0 dB = 0.626 W/kg = -2.03 dBW/kg





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Right with RF Lif3 Chip 14-11-16

Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;

Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.44$ S/m; $\varepsilon_r = 38.3$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right with RF Lif3 Chip 14-11-16/Channel 9400 Test 2/Area Scan (141x81x1): Interpolated grid:

dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.215 W/kg

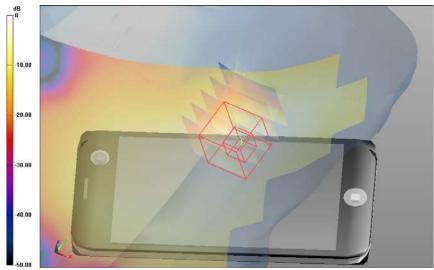
Touch Right with RF Lif3 Chip 14-11-16/Channel 9400 Test 2/Zoom Scan (21x21x36)/Cube 0:

Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 9.725 V/m; Power Drift = -

0.17 dB

Averaged SAR: SAR(1g) = 0.183 W/kg; SAR(10g) = 0.113 W/kg

Maximum value of SAR (interpolated) = 0.263 W/kg



0 dB = 0.215 W/kq = -6.68 dBW/kq





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Right No Chip 14-11-16

Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;

Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.44$ S/m; $\varepsilon_r = 38.3$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right No Chip 14-11-16/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm,

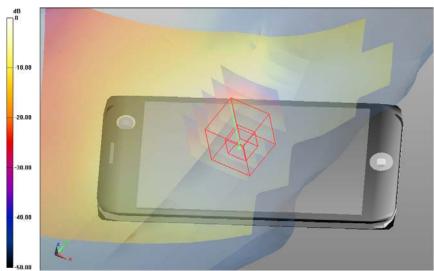
dy=1.5 mm; Maximum value of SAR (interpolated) = 0.557 W/kg

Touch Right No Chip 14-11-16/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid:

dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 20.973 V/m; Power Drift = -0.07 dB

Averaged SAR: SAR(1g) = 0.526 W/kg; SAR(10g) = 0.422 W/kg

Maximum value of SAR (interpolated) = 0.576 W/kg



0 dB = 0.557 W/kg = -2.54 dBW/kg





DUT Name: Dipole 1950 MHz, Type: DV1950V3, Serial: 1113

Configuration: System Check 14-11-16

Communication System: 0 - System Check; Communication System Band: 1800 MHz; Frequency: 1800

MHz, Communication System PAR: 0.00 dB; PMF: 0.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1799.9 MHz; σ = 1.39 S/m; ϵ_r = 38.5; ρ = 1000.0g/cm³

Phantom section: Flat Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

System Check 14-11-16/Channel 1 Test/Area Scan (51x51x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;

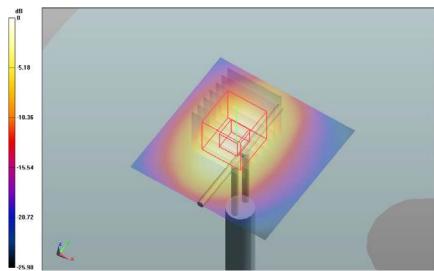
Maximum value of SAR (interpolated) = 10.900 W/kg

System Check 14-11-16/Channel 1 Test/Zoom Scan (31x31x36)/Cube 0: Interpolated grid: dx=1.0

mm, dy=1.0 mm, dz=1.0 mm; Reference Value = 89.315 V/m; Power Drift = 0.04 dB

Averaged SAR: SAR(1g) = 8.920 W/kg; SAR(10g) = 4.730 W/kg

Maximum value of SAR (interpolated) = 15.300 W/kg



0 dB = 10.9 W/kg = 10.37 dBW/kg





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Left with RF Lif3 Chip 14-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; $\sigma = 0.88$ S/m; $\varepsilon_r = 41.5$; $\rho = 1000.0$ g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left with RF Lif3 Chip 14-11-16/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid:

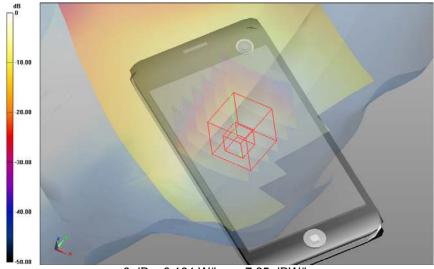
dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.164 W/kg

Touch Left with RF Lif3 Chip 14-11-16/Channel 4183 Test/Zoom Scan (26x26x36)/Cube 0:

Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 14.304 V/m; Power Drift = -0.07 dB

Averaged SAR: SAR(1g) = 0.156 W/kg; SAR(10g) = 0.119 W/kg

Maximum value of SAR (interpolated) = 0.193 W/kg



0 dB = 0.164 W/kq = -7.85 dBW/kq





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Left No Chip 14-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; $\sigma = 0.88$ S/m; $\varepsilon_r = 41.5$; $\rho = 1000.0$ g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left No Chip 14-11-16/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm,

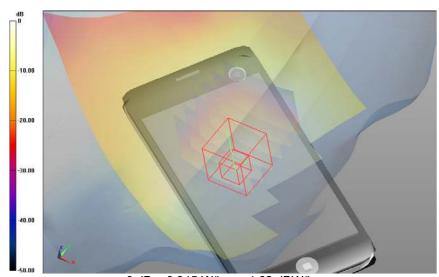
dy=1.5 mm; Maximum value of SAR (interpolated) = 0.345 W/kg

Touch Left No Chip 14-11-16/Channel 4183 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid:

dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 20.514 V/m; Power Drift = -0.05 dB

Averaged SAR: SAR(1g) = 0.326 W/kg; SAR(10g) = 0.249 W/kg

Maximum value of SAR (interpolated) = 0.407 W/kg



0 dB = 0.345 W/kg = -4.62 dBW/kg





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Right with RF Lif3 Chip 14-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; $\sigma = 0.88$ S/m; $\varepsilon_r = 41.5$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

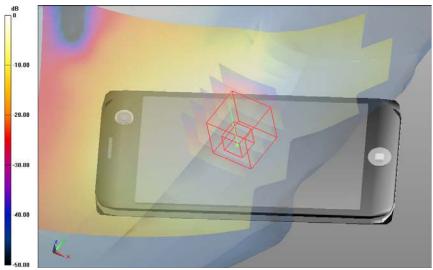
Touch Right with RF Lif3 Chip 14-11-16/Channel 4183 Test 2/Area Scan (141x81x1): Interpolated grid:

dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.181 W/kg

Touch Right with RF Lif3 Chip 14-11-16/Channel 4183 Test 2/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 14.856 V/m; Power Drift = 0.08 dB

Averaged SAR: SAR(1g) = 0.174 W/kg; SAR(10g) = 0.134 W/kg

Maximum value of SAR (interpolated) = 0.211 W/kg



0 dB = 0.181 W/kq = -7.42 dBW/kq





DUT Name: Apple Mobile Phone, Type: iPhone 7, Serial: C6KSC3BQHG7F

Configuration: Touch Right No Chip 14-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; $\sigma = 0.88$ S/m; $\varepsilon_r = 41.5$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right No Chip 14-11-16/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm,

dy=1.5 mm; Maximum value of SAR (interpolated) = 0.288 W/kg

Touch Right No Chip 14-11-16/Channel 4183 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid:

dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 18.811 V/m; Power Drift = -0.00 dB

Averaged SAR: SAR(1g) = 0.273 W/kg; SAR(10g) = 0.213 W/kg

Maximum value of SAR (interpolated) = 0.325 W/kg



0 dB = 0.288 W/kg = -5.41 dBW/kg





DUT Name: Dipole 900 MHz, Type: DV900V2, Serial: 047

Configuration: System Check 14-11-16

Communication System: 0 - CW; Communication System Band: 900 MHz; Frequency: 900.0 MHz,

Communication System PAR: 0.00 dB; PMF: 0.00; Duty Cycle: 1:1.00

Medium Parameters used: f=900 MHz; $\sigma = 0.94$ S/m; $\varepsilon_r = 40.8$; $\rho = 1000.0$ g/cm³

Phantom section: Flat Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

System Check 14-11-16/Channel 1 Test/Area Scan (51x51x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;

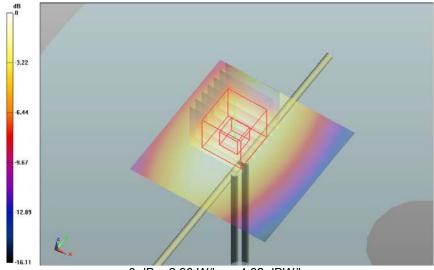
Maximum value of SAR (interpolated) = 2.900 W/kg

System Check 14-11-16/Channel 1 Test/Zoom Scan (31x31x36)/Cube 0: Interpolated grid: dx=1.0

mm, dy=1.0 mm, dz=1.0 mm; Reference Value = 57.388 V/m; Power Drift = 0.01 dB

Averaged SAR: SAR(1g) = 2.670 W/kg; SAR(10g) = 1.720 W/kg

Maximum value of SAR (interpolated) = 3.970 W/kg



0 dB = 2.90 W/kg = 4.62 dBW/kg





DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Left 1900 MHz with Life3 Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 2 1850 MHz; Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.47$ S/m; $\varepsilon_r = 38.7$; $\rho = 1000.0$ g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection (Locations From Previous Scan Used))

Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

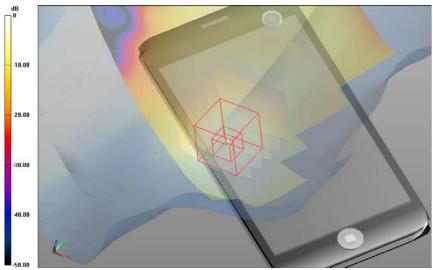
Touch Left 1900 MHz with Life3 Chip 15-11-16/Channel 9400 Test 2/Area Scan (141x81x1): Interpolated

grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.104 W/kg

Touch Left 1900 MHz with Life3 Chip 15-11-16/Channel 9400 Test 2/Zoom Scan (26x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 8.658 V/m; Power Drift = -0.04 dB

Averaged SAR: SAR(1g) = 0.092 W/kg; SAR(10g) = 0.057 W/kg

Maximum value of SAR (interpolated) = 0.137 W/kg



0 dB = 0.104 W/kq = -9.83 dBW/kq





DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Left 1900 MHz No Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 2 1850 MHz; Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.47$ S/m; $\varepsilon_r = 38.7$; $\rho = 1000.0$ g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

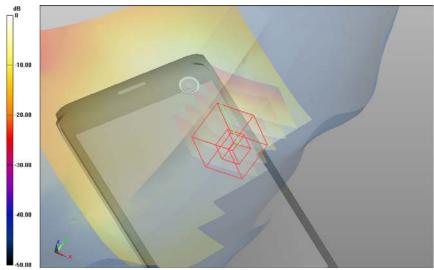
Touch Left 1900 MHz No Chip 15-11-16/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid:

dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.247 W/kg

Touch Left 1900 MHz No Chip 15-11-16/Channel 9400 Test/Zoom Scan (26x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 10.410 V/m; Power Drift = 0.01 dB

Averaged SAR: SAR(1g) = 0.242 W/kg; SAR(10g) = 0.160 W/kg

Maximum value of SAR (interpolated) = 0.326 W/kg



0 dB = 0.247 W/kq = -6.07 dBW/kq





DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Right 1900 MHz with Life3 Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 2 1850 MHz; Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.47$ S/m; $\varepsilon_r = 38.7$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

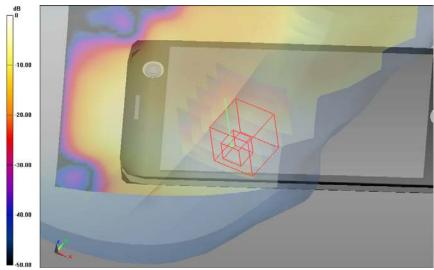
Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right 1900 MHz with Life3 Chip 15-11-16/Channel 9400 Test with Life3 Chip/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.049 W/kg Touch Right 1900 MHz with Life3 Chip 15-11-16/Channel 9400 Test with Life3 Chip/Zoom Scan (26x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 3.071 V/m; Power Drift = -0.16 dB

Averaged SAR: SAR(1g) = 0.043 W/kg; SAR(10g) = 0.028 W/kg

Maximum value of SAR (interpolated) = 0.061 W/kg



0 dB = 0.0488 W/kq = -13.12 dBW/kq





DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Right 1900 MHz No Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 2 1850 MHz; Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1880 MHz; $\sigma = 1.47$ S/m; $\varepsilon_r = 38.7$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right 1900 MHz No Chip 15-11-16/Channel 9400 Test with Life3 Chip/Area Scan (141x81x1):

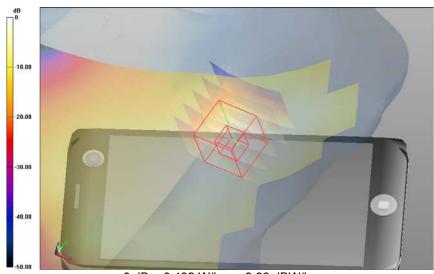
Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.402 W/kg Touch Right 1900 MHz No Chip 15-11-16/Channel 9400 Test with Life3 Chip/Zoom Scan

(26x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 12.554

V/m; Power Drift = 0.08 dB

Averaged SAR: SAR(1g) = 0.345 W/kg; SAR(10g) = 0.218 W/kg

Maximum value of SAR (interpolated) = 0.488 W/kg



0 dB = 0.402 W/kq = -3.96 dBW/kq





DUT Name: Dipole 1950 MHz, Type: DV1950V3, Serial: 1113

Configuration: System Check 15-11-16

Communication System: 0 - System Check; Communication System Band: 1800 MHz; Frequency: 1800

MHz, Communication System PAR: 0.00 dB; PMF: 0.00; Duty Cycle: 1:1.00

Medium Parameters used: f=1799.9 MHz; σ = 1.41 S/m; ε_r = 39.0; ρ = 1000.0g/cm³

Phantom section: Flat Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (5.12,5.12,5.12); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442: Calibrated: 7/12/2015 Phantom: SAM 22; Type: SAM 22; Serial: 1260

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

System Check 15-11-16/Channel 1 Test/Area Scan (51x51x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;

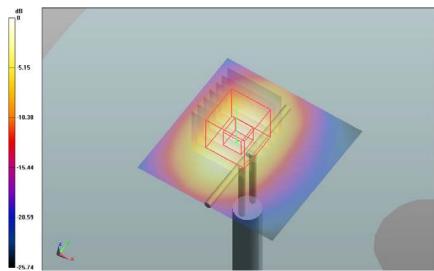
Maximum value of SAR (interpolated) = 10.800 W/kg

System Check 15-11-16/Channel 1 Test/Zoom Scan (31x31x36)/Cube 0: Interpolated grid: dx=1.0

mm, dy=1.0 mm, dz=1.0 mm; Reference Value = 85.602 V/m; Power Drift = -0.03 dB

Averaged SAR: SAR(1g) = 9.000 W/kg; SAR(10g) = 4.780 W/kg

Maximum value of SAR (interpolated) = 15.500 W/kg



0 dB = 10.8 W/kg = 10.33 dBW/kg





Control of the contro

Test Lab: EMCTech Test File: M161013 iPhone 7 Plus 850 MHz 3G EN.da52:0

DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Left with Lef3 Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; σ = 0.89 S/m; ε_r = 42.2; ρ = 1000.0g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

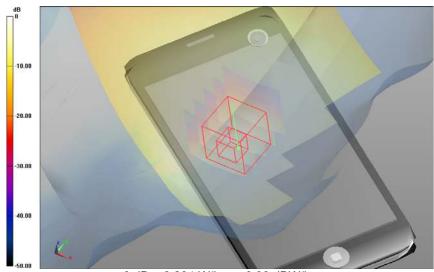
Touch Left with Lef3 Chip 15-11-16/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5

mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.204 W/kg

Touch Left with Lef3 Chip 15-11-16/Channel 4183 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated

grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 15.367 V/m; Power Drift = -0.07 dB Averaged SAR: SAR(1g) = 0.195 W/kg; SAR(10g) = 0.149 W/kg

Maximum value of SAR (interpolated) = 0.245 W/kg



0 dB = 0.204 W/kg = -6.90 dBW/kg





Test Lab: EMCTech Test File: M161013 iPhone 7 Plus 850 MHz 3G EN.da52:1

DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Left No Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; $\sigma = 0.89$ S/m; $\varepsilon_r = 42.2$; $\rho = 1000.0$ g/cm³

Phantom section: Left Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left No Chip 15-11-16/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm,

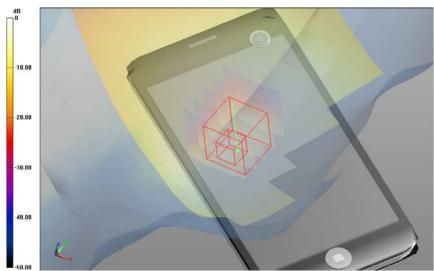
dy=1.5 mm; Maximum value of SAR (interpolated) = 0.283 W/kg

Touch Left No Chip 15-11-16/Channel 4183 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid:

dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 17.922 V/m; Power Drift = 0.01 dB

Averaged SAR: SAR(1g) = 0.270 W/kg; SAR(10g) = 0.206 W/kg

Maximum value of SAR (interpolated) = 0.340 W/kg



0 dB = 0.283 W/kg = -5.48 dBW/kg





Test Lab: EMCTech Test File: M161013 iPhone 7 Plus 850 MHz 3G EN.da52:2

DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Right with Life3 Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; $\sigma = 0.89$ S/m; $\varepsilon_r = 42.2$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right with Life3 Chip 15-11-16/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid:

dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.173 W/kg

Touch Right with Life3 Chip 15-11-16/Channel 4183 Test/Zoom Scan (21x21x36)/Cube 0:

Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 14.334 V/m; Power Drift = 0.03 dB

Averaged SAR: SAR(1g) = 0.168 W/kg; SAR(10g) = 0.133 W/kg

Maximum value of SAR (interpolated) = 0.196 W/kg



0 dB = 0.173 W/kq = -7.62 dBW/kq





Orix restriction. School Elio to Apple in hone 7 and 7 has phones - Report No.: Wife 10 to 7 age 40 of 70

Test Lab: EMCTech Test File: M161013 iPhone 7 Plus 850 MHz 3G EN.da52:3

DUT Name: Apple Mobile Phone, Type: iPhone 7 Plus, Serial: C39SGABDHFYF

Configuration: Touch Right No Chip 15-11-16

Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz; Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00

Medium Parameters used: f=836.5 MHz; $\sigma = 0.89$ S/m; $\varepsilon_r = 42.2$; $\rho = 1000.0$ g/cm³

Phantom section: Right Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right No Chip 15-11-16/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm,

dy=1.5 mm; Maximum value of SAR (interpolated) = 0.230 W/kg

Touch Right No Chip 15-11-16/Channel 4183 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid:

dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 16.430 V/m; Power Drift = 0.01 dB

Averaged SAR: SAR(1g) = 0.221 W/kg; SAR(10g) = 0.175 W/kg

Maximum value of SAR (interpolated) = 0.262 W/kg



0 dB = 0.230 W/kg = -6.38 dBW/kg





Test Lab: EMCTech Test File: M161013 iPhone 7 Plus 850 MHz 3G EN.da52:4

DUT Name: Dipole 900 MHz, Type: DV900V2, Serial: 047

Configuration: System Check 15-11-16

Communication System: 0 - CW; Communication System Band: 900 MHz; Frequency: 900.0 MHz,

Communication System PAR: 0.00 dB; PMF: 0.00; Duty Cycle: 1:1.00

Medium Parameters used: f=900 MHz; σ = 0.96 S/m; ε_r = 41.5; ρ = 1000.0g/cm³

Phantom section: Flat Section

DASY Configuration:

Probe: ET3DV6 - SN1380; ConvF: (6.08,6.08,6.08); Calibrated: 10/12/2015;

Sensor-Surface: 4 mm (Mechanical Surface Detection) Electronics: DAE3 Sn442; Calibrated: 7/12/2015 Phantom: SAM 12; Type: SAM 12; Serial: 1060

DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

System Check 15-11-16/Channel 1 Test/Area Scan (51x51x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;

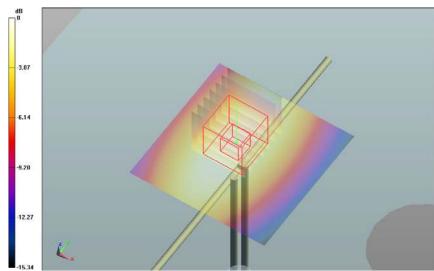
Maximum value of SAR (interpolated) = 2.970 W/kg

System Check 15-11-16/Channel 1 Test/Zoom Scan (31x31x36)/Cube 0: Interpolated grid: dx=1.0

mm, dy=1.0 mm, dz=1.0 mm; Reference Value = 57.805 V/m; Power Drift = 0.06 dB

Averaged SAR: SAR(1g) = 2.740 W/kg; SAR(10g) = 1.760 W/kg

Maximum value of SAR (interpolated) = 4.060 W/kg



0 dB = 2.97 W/kg = 4.73 dBW/kg





APPENDIX C DESCRIPTION OF SAR MEASUREMENT SYSTEM

Probe Positioning System

The measurements were performed with the state of the art automated near-field scanning system DASY5 Version 52 (Build 1222) from Schmid & Partner Engineering AG (SPEAG). The system is based on a high precision 6-axis robot (working range greater than 1.1m), which positions the SAR measurement probes with a positional repeatability of better than ±0.02 mm. The DASY5 fully complies with the IEEE 1528 and EN62209 SAR measurement requirements.

E-Field Probe Type and Performance

The SAR measurements were conducted with the dosimetric probe ET3DV6 was used (manufactured by SPEAG). The SAR probes are designed in the classical triangular configuration and optimised for dosimetric evaluation. The probe has been calibrated and found to be accurate to better than ±0.25 dB. The probe is suitable for measurements close to material discontinuity at the surface of the phantom.

Data Acquisition Electronics

The data acquisition electronics (DAE3) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. The input impedance of the DAE3 box is 200 $M\Omega$; the inputs are symmetrical and floating. Common mode rejection is above 80dB. Transmission to the PC-card is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The mechanical probe-mounting device includes two different sensor systems for frontal and sideways probe contacts. They are used for mechanical surface detection and probe collision detection.

Device Holder for DASY5

The DASY5 device holder supplied by SPEAG is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear openings). The rotation centres for both scales is the ear opening. Thus the device needs no repositioning when changing the angles.

The DASY5 device holder is made of low-loss material having the following dielectric parameters: relative permittivity ε =3 and loss tangent δ =0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, to reduce the influence on the clamp on the test results.

Refer to Appendix A for photograph of device positioning.

Liquid Depth 15cm

During the SAR measurement process the liquid level was maintained to a level of a least 15cm with a tolerance of \pm 0.5cm.





Phantom Properties (Size, Shape, Shell Thickness, Tissue Material Properties)

The phantom used during the SAR testing and validation was the "SAM" phantom from SPEAG. The phantom thickness is 2.0mm+/-0.2 mm and was filled with the required tissue simulating liquid.

The dielectric parameters of the simulating liquid were measured prior to SAR assessment using the HP85070A dielectric probe kit and HP8753ES Network Analyser. The target dielectric parameters are shown in the following table.

Table: Target Simulating Liquid Dielectric Values UMTS Bands

Table. Target Simulating Liquid Dielectric Values OM 13 Bands						
	Frequency (MHz)	∈r (target)	σ (target)	ρ kg / m ³		
Band	UMTS Band 2					
	1852.4	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000		
Frequency (MHz)	1880	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000		
	1907.6	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000		
Band	UMTS Band 5					
	826.4	41.5 ±5% (39.4 to 43.6)	0.90 ±5% (0.86 to 0.95)	1000		
Frequency (MHz)	836.6	41.5 ±5% (39.4 to 43.6)	0.90 ±5% (0.86 to 0.95)	1000		
	846.6	41.5 ±5% (39.4 to 43.6)	0.90 ±5% (0.86 to 0.95)	1000		

Note: The liquid parameters were within the required tolerances of $\pm 5\%$.

Simulated Tissue Composition Used for SAR Test

The tissue simulating liquids are created prior to the SAR evaluation and often require slight modification each day to obtain the correct dielectric parameters.

Table: Tissue Type: @ 850/900MHz Volume of Liquid: 30 Litres

Approximate Composition	% By Weight
Distilled Water	41.05
Salt	1.35
Sugar	56.5
HEC	1.0
Bactericide	0.1

Approximate Composition	% By Weight
Distilled Water	61.17
Salt	0.31
Bactericide	0.29
Triton X-100	38.23

Table: Tissue Type: @ 1800/1950MHz

Volume of Liquid: 30 Litres





APPENDIX D CALIBRATION DOCUMENTS

- 1. ET3DV6 SN: 1380 Probe Calibration Certificate
- 2. SN: 047 D900V2 Dipole Calibration Certificate
- 3. SN: 242 D1800V2 Dipole Calibration Certificate
- 4. SN: 442 DAE3 Data Acquisition Electronics Calibration Certificate





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Client EMC Technologies

Accreditation No.: SCS 0108

Certificate No: ET3-1380_Dec15

CALIBRATION CERTIFICATE

Object

ET3DV6 - SN:1380

Calibration procedure(s)

QA CAL-01.v9, QA CAL-12.v9, QA CAL-23.v5, QA CAL-25.v6

Calibration procedure for dosimetric E-field probes

Calibration date:

December 10, 2015

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).

The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	01-Apr-15 (No. 217-02128)	Mar-16
Power sensor E4412A	MY41498087	01-Apr-15 (No. 217-02128)	Mar-16
Reference 3 dB Attenuator	SN: S5054 (3c)	01-Apr-15 (No. 217-02129)	Mar-16
Reference 20 dB Attenuator	SN: S5277 (20x)	01-Apr-15 (No. 217-02132)	Mar-16
Reference 30 dB Attenuator	SN: S5129 (30b)	01-Apr-15 (No. 217-02133)	Mar-16
Reference Probe ES3DV2	SN: 3013	30-Dec-14 (No. ES3-3013_Dec14)	Dec-15
DAE4	SN: 660	14-Jan-15 (No. DAE4-660_Jan15)	Jan-16
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-13)	In house check: Apr-16
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16

Name Function Signature

Calibrated by: Jeton Kastrati Laboratory Technician

Approved by: Kalja Pokovic Technical Manager

Issued: December 10, 2015

This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: ET3-1380_Dec15

Page 1 of 11









Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura **Swiss Calibration Service**

Accreditation No.: SCS 0108

Report No.: M161013 Page 46 of 76

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

tissue simulating liquid TSL NORMx,y,z sensitivity in free space ConvF sensitivity in TSL / NORMx,y,z DCP diode compression point

CF crest factor (1/duty_cycle) of the RF signal A, B, C, D modulation dependent linearization parameters

Polarization o φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., $\theta = 0$ is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement
- Techniques", June 2013
 IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010 d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not affect the E2-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: ET3-1380 Dec15

Page 2 of 11





ET3DV6 - SN:1380

December 10, 2015

Probe ET3DV6

SN:1380

Manufactured: Calibrated:

August 16, 1999 December 10, 2015

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: ET3-1380_Dec15

Page 3 of 11





ET3DV6-SN:1380

December 10, 2015

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (μV/(V/m) ²) ^A	1.65	1.59	1.69	± 10.1 %
DCP (mV) ^B	96.4	95.6	96.5	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√μV	С	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	250.1	±3.5 %
		Y	0.0	0.0	1.0		227.8	
		Z	0.0	0.0	1.0		253.2	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ET3-1380_Dec15

Page 4 of 11





A The uncertainties of Norm X,Y,Z do not affect the E2-field uncertainty inside TSL (see Pages 5 and 6).

B Numerical linearization parameter: uncertainty not required.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Report No.: M161013 Page 49 of 76

ET3DV6-SN:1380

December 10, 2015

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc (k=2)
300	45.3	0.87	7.96	7.96	7.96	0.24	2.85	± 13.3 %
450	43.5	0.87	7.17	7.17	7.17	0.27	2.85	± 13.3 %
750	41.9	0.89	6.49	6.49	6.49	0.31	3.00	± 12.0 %
900	41.5	0.97	6.08	6.08	6.08	0.32	3.00	± 12.0 %
1640	40.3	1.29	5.35	5.35	5.35	0.69	2.25	± 12.0 %
1810	40.0	1.40	5.12	5.12	5.12	0.80	2.11	± 12.0 %
1950	40.0	1.40	4.94	4.94	4.94	0.80	2.07	± 12.0 %
2450	39.2	1.80	4.56	4.56	4.56	0.80	1.79	± 12.0 %

^C Frequency validity above 300 MHz of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

F At frequencies below 3 GHz, the validity of tissue parameters (c and σ) can be relaxed to ± 10% if liquid compensation formula is applied to

Certificate No: ET3-1380_Dec15

Page 5 of 11





measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to \pm 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

Galpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than \pm 1% for frequencies below 3 GHz and below \pm 2% for frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

ET3DV6-SN:1380

December 10, 2015

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

Calibration Parameter Determined in Body Tissue Simulating Media

f (MHz) ^C	Relative Permittivity F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc (k=2)
300	58.2	0.92	7.55	7.55	7.55	0.22	2.30	± 13.3 %
450	56.7	0.94	7.57	7.57	7.57	0.21	2.30	± 13.3 %
750	55.5	0.96	6.31	6.31	6.31	0.32	3.00	± 12.0 %
900	55.0	1.05	6.08	6.08	6.08	0.36	3.00	± 12.0 %
1810	53.3	1.52	4.73	4.73	4.73	0.80	2.21	± 12.0 %
1950	53.3	1.52	4.78	4.78	4.78	0.80	2.10	± 12.0 %
2450	52.7	1.95	4.18	4.18	4.18	0.90	0.90	± 12.0 %

^C Frequency validity above 300 MHz of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency

Certificate No: ET3-1380_Dec15

Page 6 of 11





below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for Convi- assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

F At frequencies below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for frequencies between 3-6 GHz at any distance larger than half the probe tip

diameter from the boundary.

ET3DV6- SN:1380 December 10, 2015

Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)

1.5 1.4 1.3 1.2 1.1 1.0 0.9 0.9 0.7 0.6 0.5 0 500 1000 1500 2000 2500 3000 f [MHz]

Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Certificate No: ET3-1380_Dec15

Page 7 of 11



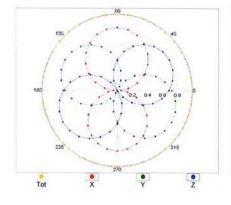


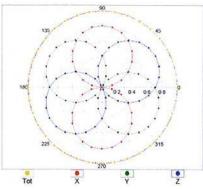
ET3DV6-SN:1380 December 10, 2015

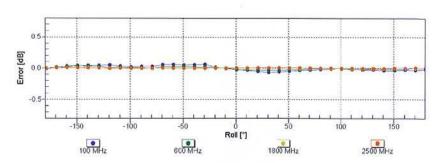
Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



f=1800 MHz,R22







Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Certificate No: ET3-1380_Dec15

Page 8 of 11



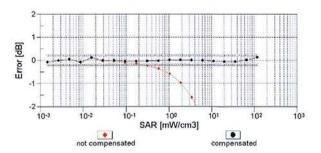


ET3DV6-SN:1380

December 10, 2015

Dynamic Range f(SAR_{head}) (TEM cell , f_{eval}= 1900 MHz)

10 105 Input Signal [uV] 102 101 10⁰ SAR [mW/cm3] 10-2 10-1 102 10-3 103 not compensated compensated



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: ET3-1380_Dec15

Page 9 of 11





ET3DV6-SN:1380 December 10, 2015 **Conversion Factor Assessment** f = 900 MHz, WGLS R9 (H_convF) f = 1810 MHz,WGLS R22 (H_convF) SAR (Veng)W 2.0 Deviation from Isotropy in Liquid Error (\$\phi\$, \$9), f = 900 MHz 1.0 0.8 0.6 0.2 0.0 -0.2 -0.4 -0.6 -0.8 -1.0 45 90 +/deg/ 180 30 y [deg] -1,0 -0.8 -0.6 -0.4 -0.2 0.0 0.2 0.4 0.6 0.8 1.0 Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)





Certificate No: ET3-1380_Dec15

ET3DV6- SN:1380

December 10, 2015

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

Other Probe Parameters

Triangular
-19.2
enabled
disabled
337 mm
10 mm
10 mm
6.8 mm
2.7 mm
2.7 mm
2.7 mm
4 mm

Certificate No: ET3-1380_Dec15

Page 11 of 11





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client EMC Technologies

Accreditation No.: SCS 108

С

Certificate No: D900V2-047_Dec14

CALIBRATION CERTIFICATE

Object D900V2 - SN: 047

Calibration procedure(s) QA CAL-05.v9

Calibration procedure for dipole validation kits above 700 MHz

Calibration date: December 09, 2014

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

ID#	Cal Date (Certificate No.)	Scheduled Calibration
GB37480704	07-Oct-14 (No. 217-02020)	Oct-15
US37292783	07-Oct-14 (No. 217-02020)	Oct-15
MY41092317	07-Oct-14 (No. 217-02021)	Oct-15
SN: 5058 (20k)	03-Apr-14 (No. 217-01918)	Apr-15
SN: 5047.2 / 06327	03-Apr-14 (No. 217-01921)	Apr-15
SN: 3205	30-Dec-13 (No. ES3-3205_Dec13)	Dec-14
SN: 601	18-Aug-14 (No. DAE4-601_Aug14)	Aug-15
ID#	Check Date (in house)	Scheduled Check
100005	04-Aug-99 (in house check Oct-13)	In house check: Oct-16
US37390585 S4206	18-Oct-01 (in house check Oct-14)	In house check: Oct-15
Name	Function	Signature
Michael Weber	Laboratory Technician	M. Weles
Katja Pokovic	Technical Manager	Stolly-
	GB37480704 US37292783 MY41092317 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 3205 SN: 601 ID # 100005 US37390585 S4206 Name Michael Weber	GB37480704 07-Oct-14 (No. 217-02020) US37292783 07-Oct-14 (No. 217-02020) MY41092317 07-Oct-14 (No. 217-02021) SN: 5058 (20k) 03-Apr-14 (No. 217-01918) SN: 5047.2 / 06327 03-Apr-14 (No. 217-01921) SN: 3205 30-Dec-13 (No. ES3-3205_Dec13) SN: 601 18-Aug-14 (No. DAE4-601_Aug14) ID # Check Date (in house) 100005 04-Aug-99 (in house check Oct-13) US37390585 S4206 18-Oct-01 (in house check Oct-14) Name Function Michael Weber Laboratory Technician

Certificate No: D900V2-047_Dec14

Page 1 of 8

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



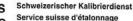


Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland







C Servizio svizzero di taratura

Report No.: M161013 Page 57 of 76

Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL

tissue simulating liquid

ConvF N/A sensitivity in TSL / NORM x,y,z

not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- EC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point.
 No uncertainty required.
- · SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: D900V2-047_Dec14

Page 2 of 8





Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	900 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.97 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.0 ± 6 %	0.94 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.59 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	10.6 W/kg ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.67 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	6.79 W/kg ± 16.5 % (k=2)

Body TSL parameters

The following parameters and calculations were applied

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.0	1.05 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	54.1 ± 6 %	1.02 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.62 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	10.7 W/kg ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	1.71 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	6.94 W/kg ± 16.5 % (k=2)

Certificate No: D900V2-047_Dec14

Page 3 of 8





Appendix (Additional assessments outside the scope of SCS108)

Antenna Parameters with Head TSL

Impedance, transformed to feed point	51.7 Ω - 4.6 jΩ	
Return Loss	- 26.4 dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	46.9 Ω - 7.0 jΩ	
Return Loss	- 22.1 dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.410 ns	
----------------------------------	----------	--

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG	
Manufactured on	October 07, 1998	

Certificate No: D900V2-047_Dec14

Page 4 of 8





DASY5 Validation Report for Head TSL

Date: 09.12.2014

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 900 MHz; Type: D900V2; Serial: D900V2 - SN: 047

Communication System: UID 0 - CW; Frequency: 900 MHz

Medium parameters used: f = 900 MHz; $\sigma = 0.94 \text{ S/m}$; $\varepsilon_r = 41$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

Probe: ES3DV3 - SN3205; ConvF(6.09, 6.09, 6.09); Calibrated: 30.12.2013;

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 18.08.2014

Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001

DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Head Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:

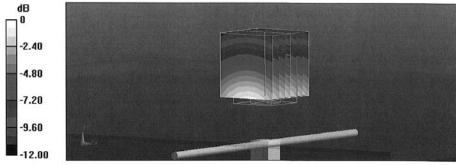
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 58.65 V/m; Power Drift = 0.00 dB

Peak SAR (extrapolated) = 3.83 W/kg

SAR(1 g) = 2.59 W/kg; SAR(10 g) = 1.67 W/kg

Maximum value of SAR (measured) = 3.04 W/kg



0 dB = 3.04 W/kg = 4.83 dBW/kg

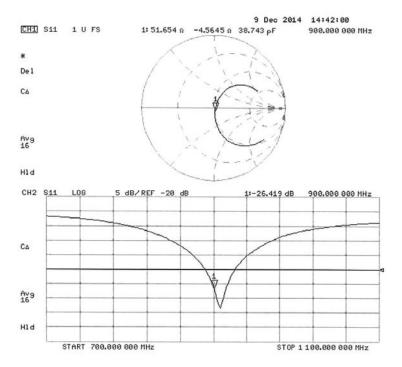
Certificate No: D900V2-047_Dec14

Page 5 of 8





Impedance Measurement Plot for Head TSL



Certificate No: D900V2-047_Dec14

Page 6 of 8





Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 900 MHz; Type: D900V2; Serial: D900V2 - SN: 047

Communication System: UID 0 - CW; Frequency: 900 MHz

Medium parameters used: f = 900 MHz; $\sigma = 1.02 \text{ S/m}$; $\varepsilon_r = 54.1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

Probe: ES3DV3 - SN3205; ConvF(5.98, 5.98, 5.98); Calibrated: 30.12.2013;

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 18.08.2014

Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001

DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Body Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:

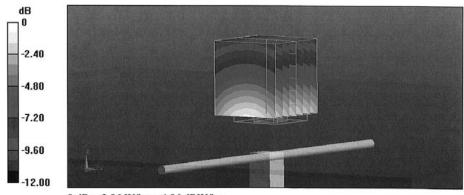
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 56.98 V/m; Power Drift = -0.01 dB

Peak SAR (extrapolated) = 3.86 W/kg

SAR(1 g) = 2.62 W/kg; SAR(10 g) = 1.71 W/kg

Maximum value of SAR (measured) = 3.06 W/kg



0 dB = 3.06 W/kg = 4.86 dBW/kg

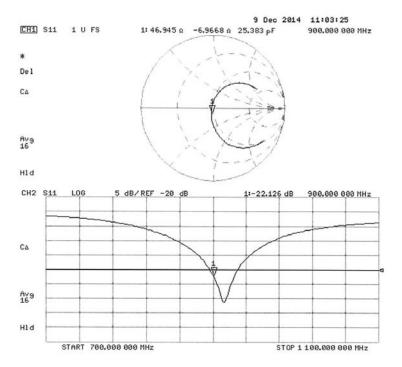
Certificate No: D900V2-047_Dec14

Page 7 of 8





Impedance Measurement Plot for Body TSL



Certificate No: D900V2-047_Dec14

Page 8 of 8





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S

C

S

Accreditation No.: SCS 108

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura **Swiss Calibration Service**

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

EMC Technologies

Certificate No: D1800V2-242_Dec14 CALIBRATION CERTIFICATE Object D1800V2 - SN: 242 Calibration procedure(s) QA CAL-05.v9 Calibration procedure for dipole validation kits above 700 MHz December 05, 2014 Calibration date: This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Scheduled Calibration Primary Standards Cal Date (Certificate No.) GB37480704 Power meter EPM-442A 07-Oct-14 (No. 217-02020) Oct-15 US37292783 Power sensor HP 8481A 07-Oct-14 (No. 217-02020) Oct-15 Power sensor HP 8481A MY41092317 07-Oct-14 (No. 217-02021) Oct-15 Reference 20 dB Attenuator SN: 5058 (20k) 03-Apr-14 (No. 217-01918) Apr-15 Type-N mismatch combination SN: 5047.2 / 06327 03-Apr-14 (No. 217-01921) Apr-15 Reference Probe ES3DV3 SN: 3205 30-Dec-13 (No. ES3-3205_Dec13) Dec-14 DAE4 SN: 601 18-Aug-14 (No. DAE4-601_Aug14) Aug-15 ID# Secondary Standards Check Date (in house) Scheduled Check RF generator R&S SMT-06 100005 04-Aug-99 (in house check Oct-13) In house check: Oct-16 US37390585 S4206 Network Analyzer HP 8753E 18-Oct-01 (in house check Oct-14) In house check: Oct-15 Function Name Calibrated by: Michael Weber Laboratory Technician Approved by: Katja Pokovic Technical Manager Issued: December 8, 2014 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D1800V2-242_Dec14







Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 108

Report No.: M161013 Page 65 of 76

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL tissue simulating liquid

ConvF sensitivity in TSL / NORM x,y,z N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- EC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point.
 No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: D1800V2-242_Dec14

Page 2 of 8





Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy , $dz = 5 mm$	
Frequency	1800 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.0 ± 6 %	1.41 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	9.73 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	38.5 W/kg ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.06 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	20.1 W/kg ± 16.5 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	51.9 ± 6 %	1.53 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition		
SAR measured	250 mW input power	9.64 W/kg	
SAR for nominal Body TSL parameters	normalized to 1W	38.2 W/kg ± 17.0 % (k=2)	

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	5.08 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	20.2 W/kg ± 16.5 % (k=2)

Certificate No: D1800V2-242_Dec14

Page 3 of 8





Appendix (Additional assessments outside the scope of SCS108)

Antenna Parameters with Head TSL

Impedance, transformed to feed point	47.6 Ω - 5.7 jΩ	
Return Loss	- 24.0 dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	44.3 Ω - 5.9 jΩ	
Return Loss	- 21.2 dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.196 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG	
Manufactured on	December 10, 1998	

Certificate No: D1800V2-242_Dec14







Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1800 MHz; Type: D1800V2; Serial: D1800V2 - SN: 242

Communication System: UID 0 - CW; Frequency: 1800 MHz

Medium parameters used: f = 1800 MHz; $\sigma = 1.41$ S/m; $\varepsilon_r = 39$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

Probe: ES3DV3 - SN3205; ConvF(5.09, 5.09, 5.09); Calibrated: 30.12.2013;

· Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 18.08.2014

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Head Tissue/Pin=250 mW, d=10mm/Zoom Scan (7x7x7)/Cube 0:

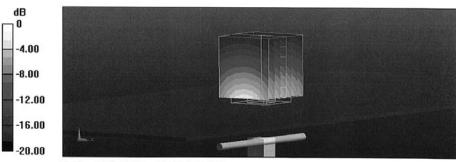
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 96.91 V/m; Power Drift = -0.01 dB

Peak SAR (extrapolated) = 18.1 W/kg

SAR(1 g) = 9.73 W/kg; SAR(10 g) = 5.06 W/kg

Maximum value of SAR (measured) = 12.4 W/kg



0 dB = 12.4 W/kg = 10.93 dBW/kg

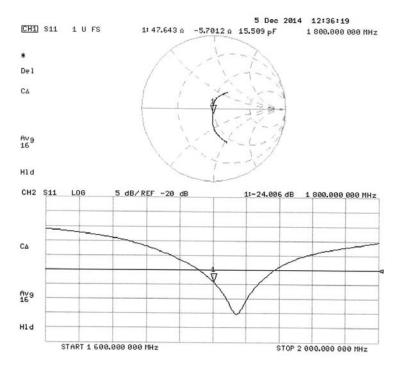
Certificate No: D1800V2-242_Dec14

Page 5 of 8





Impedance Measurement Plot for Head TSL



Certificate No: D1800V2-242_Dec14

Page 6 of 8





DASY5 Validation Report for Body TSL

Date: 05.12.2014

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1800 MHz; Type: D1800V2; Serial: D1800V2 - SN: 242

Communication System: UID 0 - CW; Frequency: 1800 MHz

Medium parameters used: f = 1800 MHz; $\sigma = 1.53$ S/m; $\varepsilon_r = 51.9$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

Probe: ES3DV3 - SN3205; ConvF(4.86, 4.86, 4.86); Calibrated: 30.12.2013;

· Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 18.08.2014

Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002

DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Body Tissue/Pin=250 mW, d=10mm/Zoom Scan (7x7x7)/Cube 0;

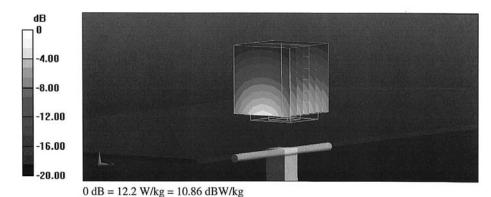
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 93.17 V/m; Power Drift = -0.02 dB

Peak SAR (extrapolated) = 17.0 W/kg

SAR(1 g) = 9.64 W/kg; SAR(10 g) = 5.08 W/kg

Maximum value of SAR (measured) = 12.2 W/kg



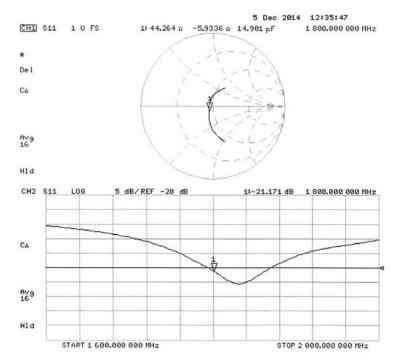
Certificate No: D1800V2-242_Dec14

Page 7 of 8





Impedance Measurement Plot for Body TSL



Certificate No: D1800V2-242_Dec14

Page 8 of 8





Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

EMC Technologies

Accreditation No.: SCS 0108

S

C

Certificate No: DAE3-442_Dec15

CALIBRATION CERTIFICATE

Object

DAE3 - SD 000 D03 AE - SN: 442

Calibration procedure(s)

QA CAL-06.v29

Calibration procedure for the data acquisition electronics (DAE)

Calibration date:

December 07, 2015

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	09-Sep-15 (No:17153)	Sep-16
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	06-Jan-15 (in house check)	In house check: Jan-16
Calibrator Box V2.1	SE UMS 006 AA 1002	06-Jan-15 (in house check)	In house check: Jan-16

Calibrated by:

Name Dominique Steffen Function

Technician

Approved by:

Fin Bomholt

Deputy Technical Manager

Issued: December 7, 2015

Signature

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE3-442_Dec15

Page 1 of 5





Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura

Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Glossary

DAE

data acquisition electronics

Connector angle information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement. Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE3-442_Dec15

Page 2 of 5





DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB =

6.1μV ,

full range = -100...+300 mV full range = -1......+3mV

Low Range: 1LSB = 61nV,

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	x	Υ	z
High Range	404.405 ± 0.02% (k=2)	405.045 ± 0.02% (k=2)	405.266 ± 0.02% (k=2)
Low Range	3.98819 ± 1.50% (k=2)	3.98159 ± 1.50% (k=2)	3.99102 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	108.0 ° ± 1 °
	100.0 I

Certificate No: DAE3-442_Dec15

Page 3 of 5





Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200038.67	1.67	0.00
Channel X + Input	20004.63	-0.23	-0.00
Channel X - Input	-20002.69	2.89	-0.01
Channel Y + Input	200037.29	0.28	0.00
Channel Y + Input	20002.85	-1.92	-0.01
Channel Y - Input	-20003.71	1.95	-0.01
Channel Z + Input	200037.94	1.15	0.00
Channel Z + Input	20004.04	-0.80	-0.00
Channel Z - Input	-20005.37	0.28	-0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2001.81	0.64	0.03
Channel X + Input	201.21	0.18	0.09
Channel X - Input	-198.79	0.14	-0.07
Channel Y + Input	2000.92	-0.05	-0.00
Channel Y + Input	200.36	-0.57	-0.28
Channel Y - Input	-199.07	-0.02	0.01
Channel Z + Input	2001.64	0.66	0.03
Channel Z + Input	199.61	-1.30	-0.65
Channel Z - Input	-201.18	-2.14	1.08

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-8.87	-10.24
	- 200	12.75	10.95
Channel Y	200	0.20	0.18
	- 200	-1.34	-1.61
Channel Z	200	-5.09	-5.43
	- 200	3.49	3.23

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-0.29	-4.08
Channel Y	200	9.19	-	0.16
Channel Z	200	6.35	6.29	

Certificate No: DAE3-442_Dec15







4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec: Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15808	17128
Channel Y	15771	16023
Channel Z	15577	15276

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.15	-1.33	2.08	0.67
Channel Y	-0.50	-2.34	1.49	0.59
Channel Z	-0.96	-3.35	1.51	0.80

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



